

NLG4305

1 : 16 DEMUX

The NLG4305 is an ultra-fast 1:16 demultiplexer. It divides serial input signal operating at up to 12.5 Gb/s into 16 parallel output signal as fast as 781.25 Mb/s (MIN.) .

It is designed with LSCFL (Low-power Source Coupled FET Logic) .

Owing to built-in 50-ohm termination resistors, external termination resistors are unnecessary for impedance matching.

The NLG4305 is fabricated using the 0.15- μ m gate length A-SAINT (Advanced Self-Aligned Implantation for N⁺ layer Technology) process.

FEATURES

Ultra-high speed :	maximum clock frequency	f _{MAX} : 12.5 GHz	[T _c = 25°C, MIN.]
	minimum clock frequency	f _{MIN} : 2.0 GHz	[T _c = 25°C, MAX.]
	output rise time	t _r = 190 ps (20-80 %)	[T _c = 25°C, TYP.]
	output fall time	t _f = 190 ps (20-80 %)	[T _c = 25°C, TYP.]

High reliability : Hermetically-sealed package

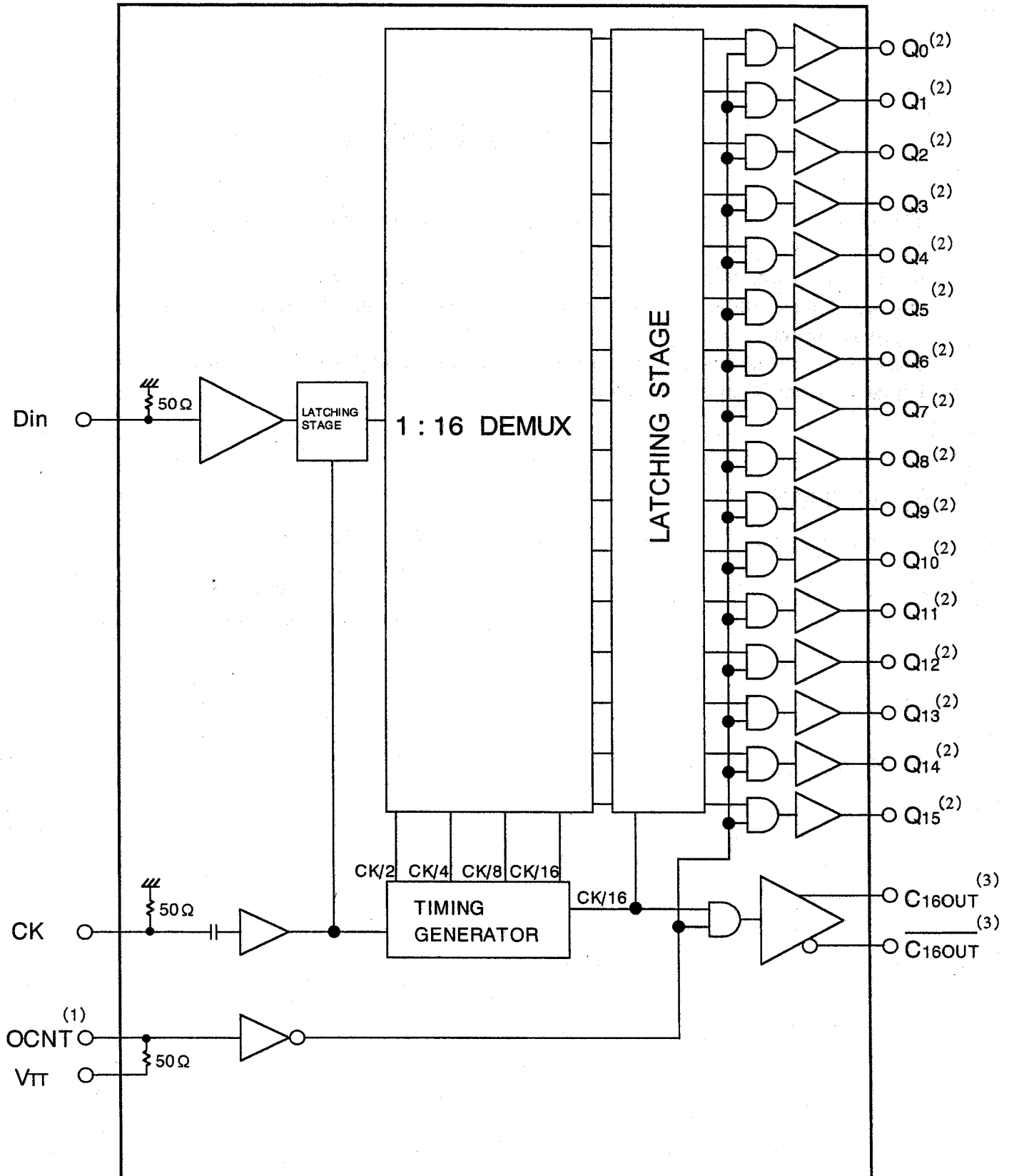
APPLICATIONS

- Serial-to-parallel converters
- High speed testers
- Digital transmission system receivers
- Computer links
- Board links

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NLG4305

FUNCTIONAL DIAGRAM

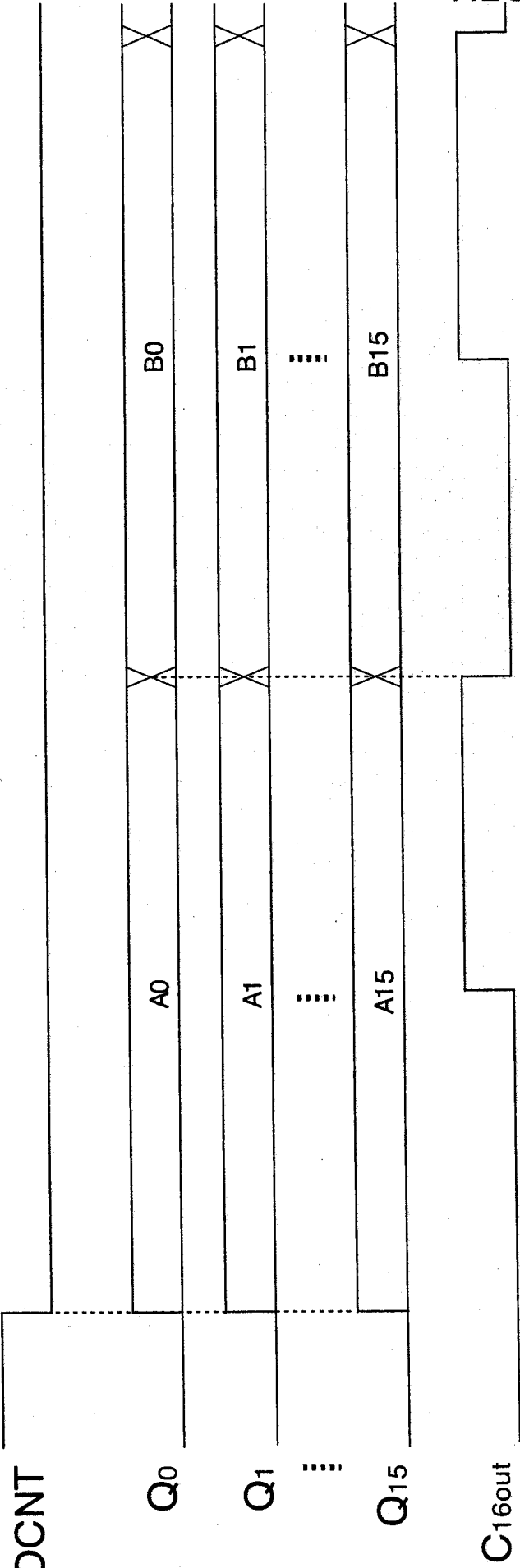
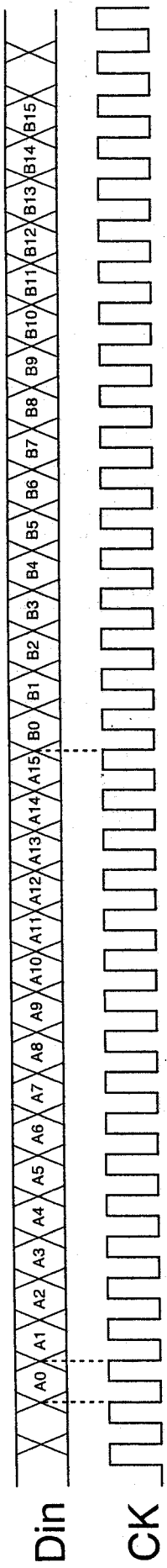


Notes

- (1) OCNT : When input is high level, Q0~Q15 and C16OUT are low level, and C16OUT is high level.
- (2) Data output terminals. (ECL output)
- (3) 1/16 clock output terminals. (ECL output)

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TIMING CHART



NLG4305

PIN CONNECTION TABLE

No.	NAME	FUNCTION	No.	NAME	FUNCTION
1	GND	Ground (0.0V)	43	GND	Ground (0.0V)
2	NC	No Internal Connection	44	VSS	Power Supply (- 3.5 V)
3	GND	Ground (0.0V)	45	GND	Ground (0.0V)
4	VTT	Input Signal Termination Power Supply (- 2.0 V)	46	Q14	1/16 Data Output 14 ⁽⁴⁾
5	GND	Ground (0.0V)	47	GND	Ground (0.0V)
6	OCNT	Output Control Input	48	Q2	1/16 Data Output 2 ⁽⁴⁾
7	GND	Ground (0.0V)	49	GND	Ground (0.0V)
8	Vrefr	OCNT Input Ref. ⁽³⁾	50	Q10	1/16 Data Output 10 ⁽⁴⁾
9	GND	Ground (0.0V)	51	GND	Ground (0.0V)
10	NC	No Internal Connection	52	VSS	Power Supply (- 3.5 V)
11	GND	Ground (0.0V)	53	GND	Ground (0.0V)
12	NC	No Internal Connection	54	C16OUT	1/16 Clock Output (Comp.) ⁽⁴⁾
13	GND	Ground (0.0V)	55	GND	Ground (0.0V)
14	Din	Data Input	56	C16OUT	1/16 Clock Output (True) ⁽⁴⁾
15	GND	Ground (0.0V)	57	GND	Ground (0.0V)
16	Vrefd	Data Input Ref. ⁽¹⁾	58	Q11	1/16 Data Output 11 ⁽⁴⁾
17	GND	Ground (0.0V)	59	GND	Ground (0.0V)
18	Vrefc	Clock Input Ref. ⁽²⁾	60	VSS	Power Supply (- 3.5 V)
19	GND	Ground (0.0V)	61	GND	Ground (0.0V)
20	CK	Clock Input	62	Q3	1/16 Data Output 3 ⁽⁴⁾
21	GND	Ground (0.0V)	63	GND	Ground (0.0V)
22	GND	Ground (0.0V)	64	GND	Ground (0.0V)
23	GND	Ground (0.0V)	65	Q15	1/16 Data Output 15 ⁽⁴⁾
24	GND	Ground (0.0V)	66	GND	Ground (0.0V)
25	VSS	Power Supply (- 3.5 V)	67	Q7	1/16 Data Output 7 ⁽⁴⁾
26	GND	Ground (0.0V)	68	GND	Ground (0.0V)
27	VSS	Power Supply (- 3.5 V)	69	VSS	Power Supply (- 3.5 V)
28	GND	Ground (0.0V)	70	GND	Ground (0.0V)
29	Q0	1/16 Data Output 0 ⁽⁴⁾	71	Q13	1/16 Data Output 13 ⁽⁴⁾
30	GND	Ground (0.0V)	72	GND	Ground (0.0V)
31	Q8	1/16 Data Output 8 ⁽⁴⁾	73	Q5	1/16 Data Output 5 ⁽⁴⁾
32	GND	Ground (0.0V)	74	GND	Ground (0.0V)
33	Q4	1/16 Data Output 4 ⁽⁴⁾	75	VSS	Power Supply (- 3.5 V)
34	GND	Ground (0.0V)	76	GND	Ground (0.0V)
35	Q12	1/16 Data Output 12 ⁽⁴⁾	77	Q9	1/16 Data Output 9 ⁽⁴⁾
36	GND	Ground (0.0V)	78	GND	Ground (0.0V)
37	Q6	1/16 Data Output 6 ⁽⁴⁾	79	Q1	1/16 Data Output 1 ⁽⁴⁾
38	GND	Ground (0.0V)	80	GND	Ground (0.0V)
39	VSS	Power Supply (- 3.5 V)	81	NC	No Internal Connection
40	GND	Ground (0.0V)	82	GND	Ground (0.0V)
41	TCMON	Case Temperature Monitor	83	VSS	Power Supply (- 3.5 V)
42	GND	Ground (0.0V)	84	GND	Ground (0.0V)

Notes

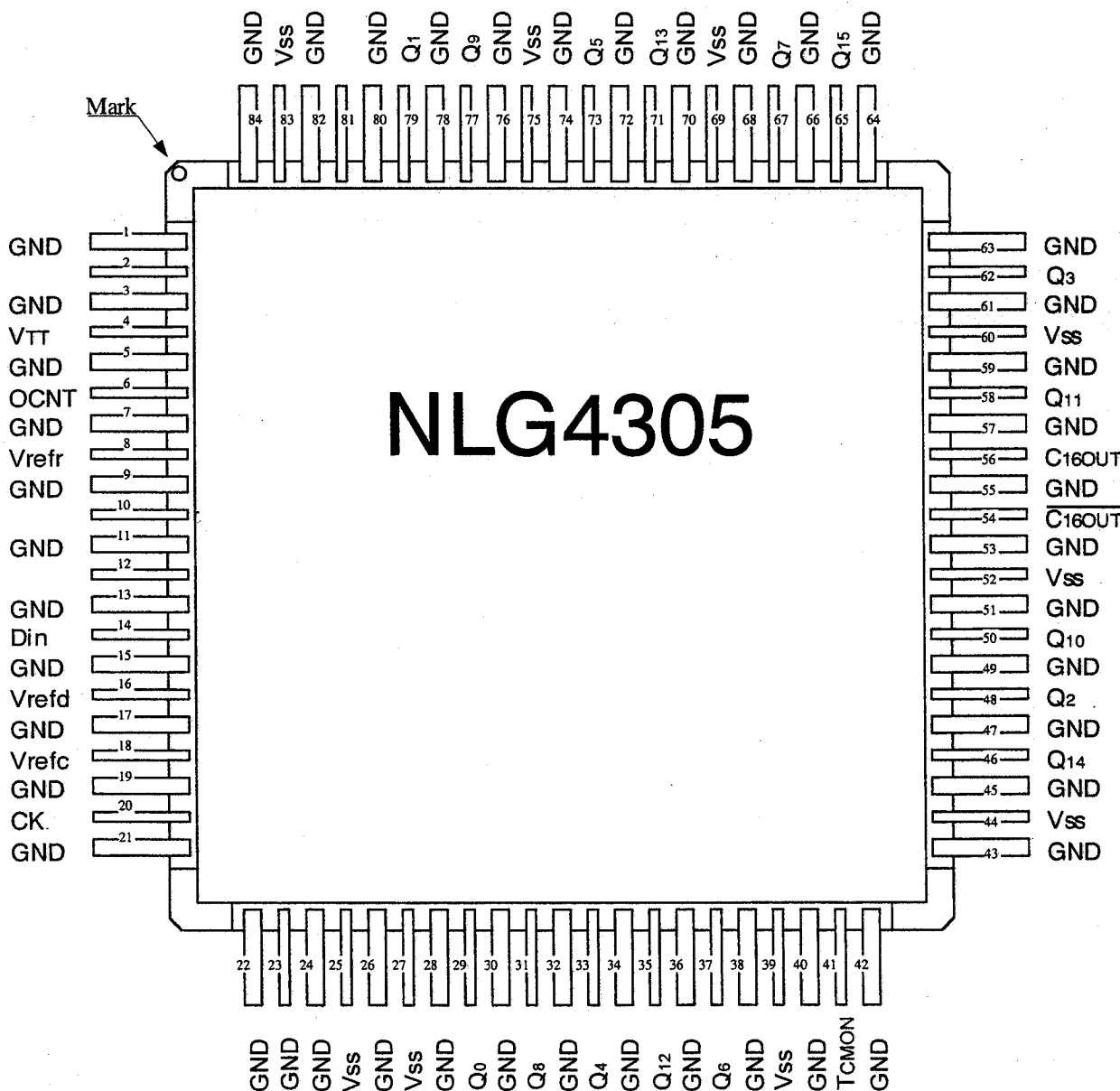
See Page 5.

PIN CONNECTION TABLE

Notes

- (1) V_{refi} : Internally generated reference voltage that determines the data input threshold level.
By applying - 0.75 to - 0.2 V externally to this pins, an arbitrary data input threshold voltage can be established.
- (2) V_{refc} : Internally generated reference voltage that determines the clock input threshold level.
By applying - 2.1 to - 1.55 V externally to this pins, an arbitrary clock input threshold voltage can be established.
- (3) V_{refr} : Internally generated reference voltage that determines the threshold level of the output control input.
By applying - 1.6 to - 1.0 V externally to this pins, an arbitrary the threshold voltage of the output control input can be established.
- (4) Terminate unused output pins to -2 V through 50-ohm resistors.

CONNECTION DIAGRAM (TOP VIEW)



ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETER	RATING
V _{SS}	Power Supply Voltage	+0.5 V ~ -4.0 V
V _{TT}	Termination Voltage	+0.5 V ~ -2.5 V
V _{indin}	Applied Voltage at Data Input (Din)	+0.3 V ~ -1.6 V
V _{in}	Applied Voltage Amplitude at Clock Input (CK)	1.6 V _{p-p}
V _{inck}	Applied Voltage at Clock Input (CK)	+1.6 V ~ -1.6 V
V _{OCNT}	Applied Voltage at Output Control Input (OCNT)	+0.3 V ~ -2.5 V
V _{oute}	Applied Voltage at Signal Outputs (Q ₀ ~ Q ₁₅ , C _{16OUT} , C _{16OUT})	+0.2 V ~ -2.5 V
V _{refd}	Applied Voltage at V _{refd} pin	+0.3 V ~ -1.6 V
V _{refc}	Applied Voltage at V _{refc} pin under Bias	-1.0 V ~ -2.5 V
V _{refr}	Applied Voltage at V _{refr} pin	+0.3 V ~ -2.5 V
V _{TCMON}	Applied Voltage at Case Temperature Monitor pin	-1.0 V ~ +1.0 V
T _{stor}	Storage Temperature	-60 °C ~ +150 °C
T _c ⁽¹⁾	Case Temperature under Bias	-60 °C ~ +125 °C

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	MIN.	TYP.	MAX.	UNITS
V _{SS}	Power Supply Voltage	-3.75	-3.5	-3.4	V
V _{TT}	Termination Voltage		-2.0		V
V _{refd}	Data Input Reference Voltage	Adjust in the range from -0.75 V to -0.2 V			V
V _{refc}	Clock Input Reference Voltage	Normally Open			V
V _{refr}	Output Control Input Reference Voltage	Normally Open			V
Din	Data Input Interface	DC Coupling (See DC Characteristics)			—
CK	Clock Input Interface	DC Coupling (See DC Characteristics) or AC Coupling (See AC Characteristics)			—
OCNT	Output Control Input Interface	Normally Open (In this condition, OCNT is set to low level)			—
OUT	Data Output, 1/16 Clock Output Interface (Q ₀ ~ Q ₁₅ , C _{16OUT} , C _{16OUT})	Terminate with 50 ohm to -2.0 V			—
TCMON	Case Temperature Monitor	Connect to a DC voltmeter for estimating case temperature. Relationship between TCMON and case temperature is shown in page 19.			—

Notes

(1) T_c : temperature at package base.

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DC CHARACTERISTICS

NLG4305

($V_{SS} = -3.75 \text{ V} \sim -3.4 \text{ V}$, $V_{TT} = -2.0 \text{ V}$, $GND = 0.0 \text{ V}$, $T_c = 0 \sim 85^\circ\text{C}$ (1))

SYMBOL	PARAMETER	MIN.	TYP.	MAX.	UNITS
V_{OHE}	Output Voltage, High ($Q_0 \sim Q_{15}$, C_{16OUT} , $\overline{C_{16OUT}}$)	-0.98	-0.75		V
V_{OLE}	Output Voltage, Low ($Q_0 \sim Q_{15}$, C_{16OUT} , $\overline{C_{16OUT}}$)	V_{TT}	-1.80	-1.57	V
V_{IH}	Input Voltage, High (D_{in} , CK)	-0.2	0.0		V
V_{IL}	Input Voltage, Low (D_{in} , CK)		-0.90	-0.75	V
V_{IHE}	Input Voltage, High (OCNT)	-1.17	-0.90		V
V_{ILE}	Input Voltage, Low (OCNT)	V_{TT}	-1.70	-1.48	V
I_{SS}	Power Supply Current (V_{SS})		1.1	1.5	A
I_{TT}	Power Supply Current (V_{TT})		24	30	mA
P_d	Power Dissipation		3.9	5.6	W

(2)

(3)

AC CHARACTERISTICS

($V_{SS} = -3.5 \text{ V}$, $V_{TT} = -2.0 \text{ V}$, $GND = 0.0 \text{ V}$, OCNT : Open,

V_{refd} : Adjust in the range from -0.75 V to -0.2 V, V_{refc} : Open, V_{refr} : Open)

SYMBOL	PARAMETER	$T_c = 0^\circ\text{C}$			$T_c = 25^\circ\text{C}$			$T_c = 85^\circ\text{C}$			UNITS
		MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
V_{in}	Minimum Clock Input Voltage Amplitude		0.5	0.6		0.5	0.6		0.5	0.6	Vp-p
f_{MAX}	Maximum Clock Frequency	12.5			12.5			12.5			GHz
f_{MIN}	Minimum Clock Frequency			2.0			2.0			2.0	GHz
t_r	Output Rise Time ($Q_0 \sim Q_{15}$, 20-80%)		190	320		190	320		200	330	ps
t_f	Output Fall Time ($Q_0 \sim Q_{15}$, 20-80%)		190	320		190	320		200	330	ps
t_{rc}	Output Rise Time (C_{16OUT} , $\overline{C_{16OUT}}$, 20-80%)		160	260		160	260		170	270	ps
t_{fc}	Output Fall Time (C_{16OUT} , $\overline{C_{16OUT}}$, 20-80%)		160	260		160	260		170	270	ps
t_{dLH}	Output Rise Delay (C_{16OUT} - $Q_0 \sim Q_{15}$)	95	145	195	100	150	200	115	165	215	ps
t_{dHL}	Output Fall Delay (C_{16OUT} - $Q_0 \sim Q_{15}$)	95	145	195	100	150	200	115	165	215	ps
t_{cLH}	Output Rise Delay (CK - C_{16OUT} , $\overline{C_{16OUT}}$)	475	525	575	480	530	580	495	545	595	ps
t_{cHL}	Output Fall Delay (CK - C_{16OUT} , $\overline{C_{16OUT}}$)	475	525	575	480	530	580	495	545	595	ps
t_{Sd}	Minimum Setup Time (D_{in} - CK)		-5	10		-5	10		0	15	ps
t_{Hd}	Minimum Hold Time (CK - D_{in})		25	40		25	40		25	40	ps

(4)

(4)

(5)

(5)

(5)

(5)

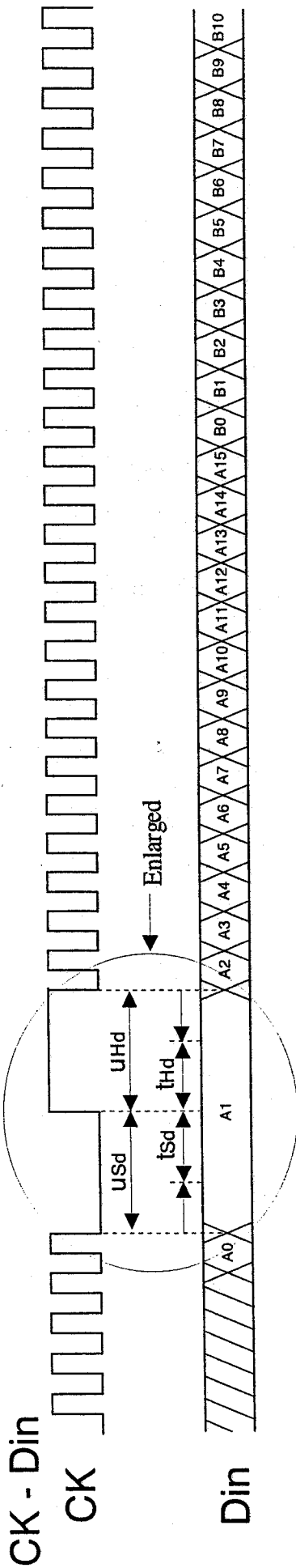
(5)

(5)

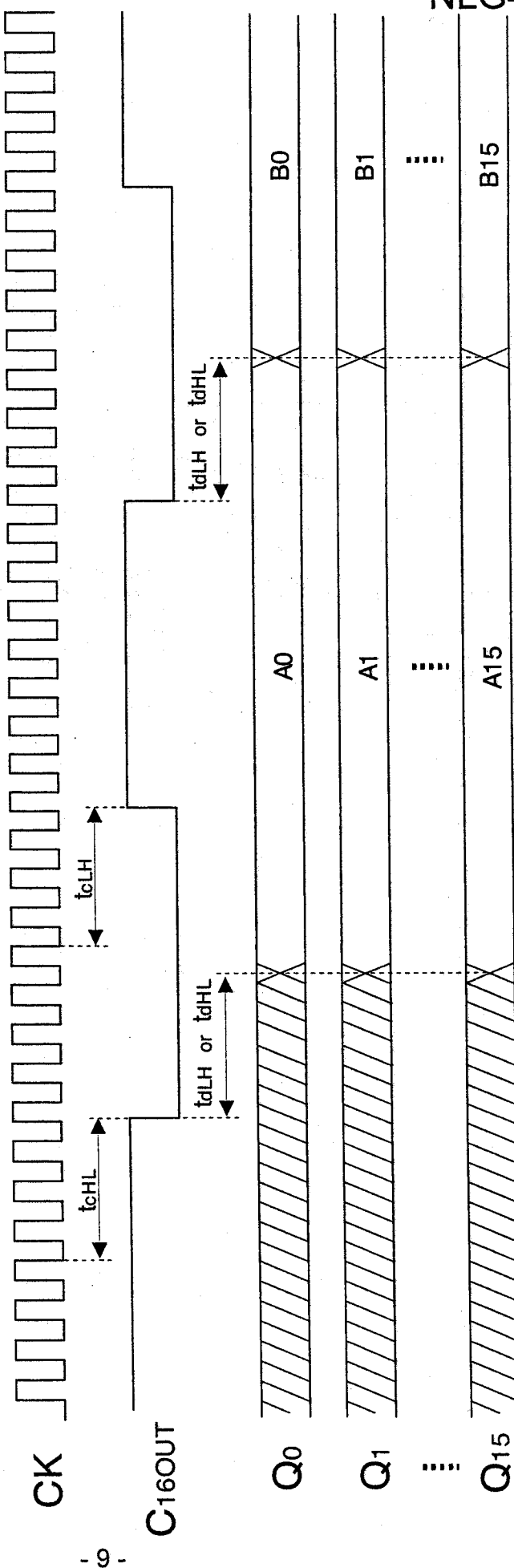
Notes

- (1) T_c : temperature at package base.
- (2) OCNT = -0.8 V
- (3) $P_d = V_{SS} \times I_{SS}$. Excludes current through input termination resistors and ECL output FETs.
- (4) Confirmed by error-free operation using a pseudo-random pattern having a word length of $2^{23}-1$ bits.
- (5) See page 9.

TIMING CHART (INCLUDING DELAY TIMES)

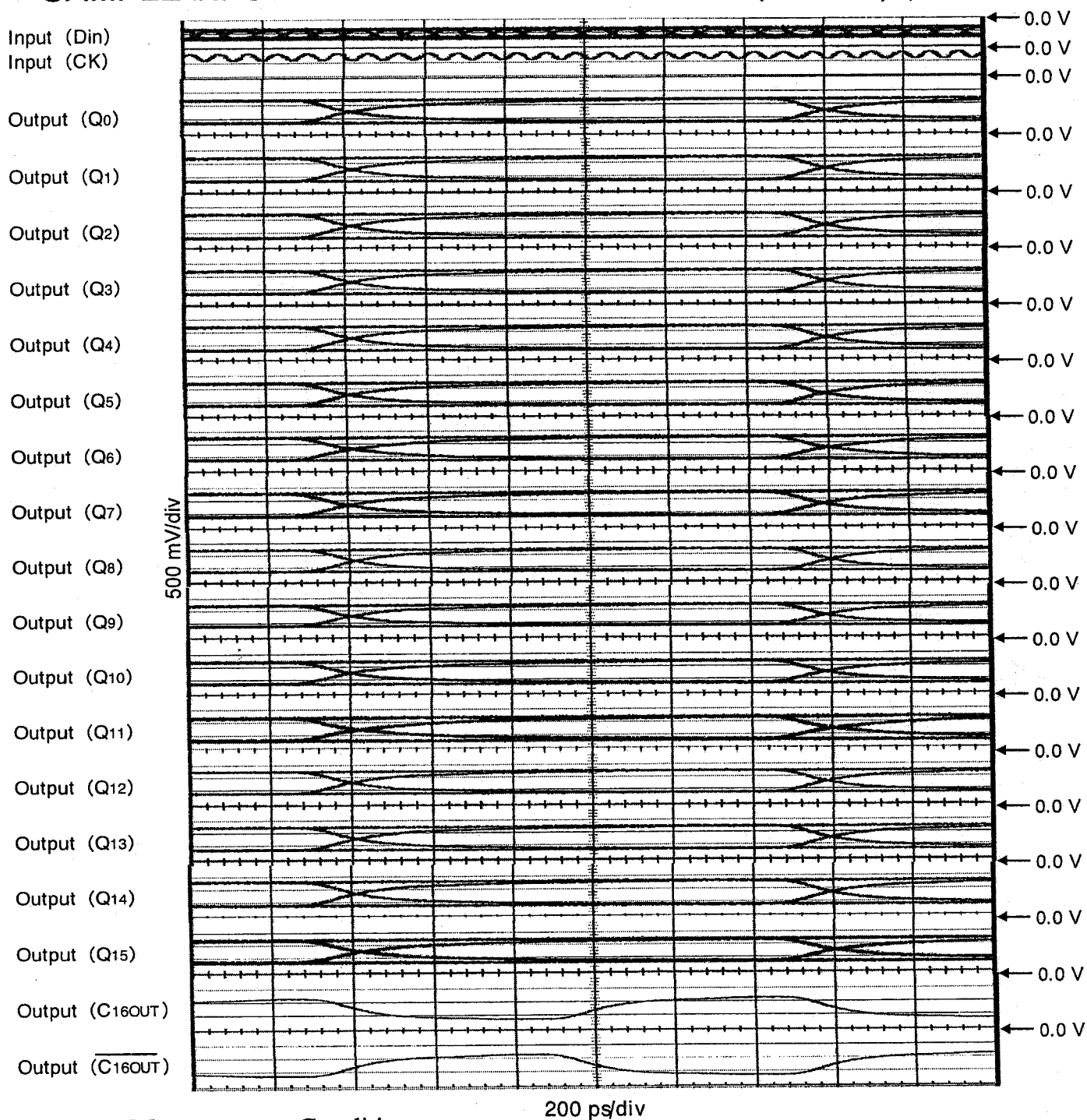


CK - C16OUT, Q0~Q15

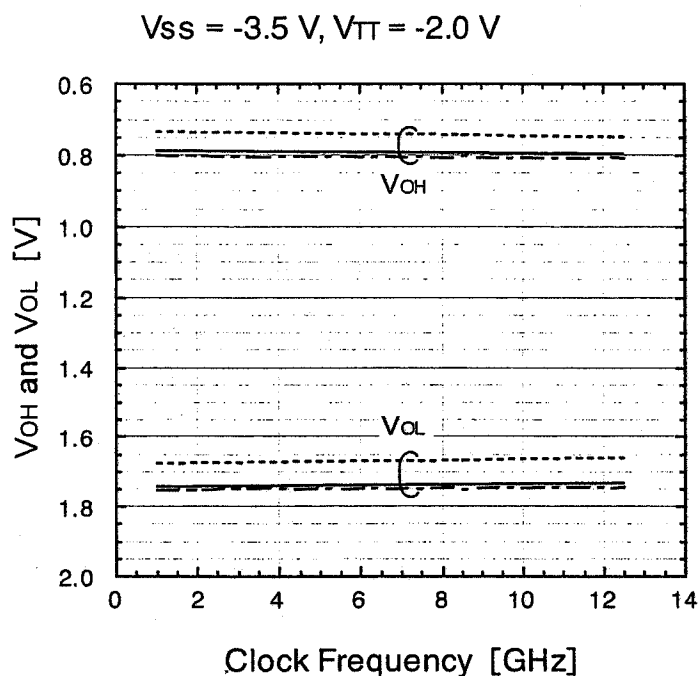


(See the timing chart on page 3 for a more complete logical description. Here, t_{sd} and t_{hd} are the minimum setup and hold times as defined on the previous page; u_{sd} and u_{hd} are the corresponding user setup and hold times.)

SAMPLE INPUT AND OUTPUT WAVEFORMS (13.5 Gb/s)

Measurement ConditionsV_{SS} = - 3.5 VV_{TT} = - 2.0 VV_{refd} = - 0.50 VV_{refc} : OpenDin : 13.5 Gb/s, P_N = 31, V_{IH} = - 0.2 V, V_{IL} = - 0.75 VCK : 13.5 GHz, V_{in} = 0.3 V_{p-p}, DC couplingT_c = 60 °C

ECL outputs (Q0~ Q15, C16OUT, $\overline{\text{C16OUT}}$) connected to the 50-ohm impedance pins of a sampling oscilloscope via ECL terminators. Results given here were obtained using the NEL test fixture.

SAMPLE AC CHARACTERISTICS (Q₀~Q₁₅)

- - - - : $T_c = 0 \text{ }^\circ\text{C}$
 ——— : $T_c = 25 \text{ }^\circ\text{C}$
 - . - . : $T_c = 85 \text{ }^\circ\text{C}$

Measurement Conditions

Din : $V_{IH} = -0.2 \text{ V}, V_{IL} = -0.75 \text{ V}$

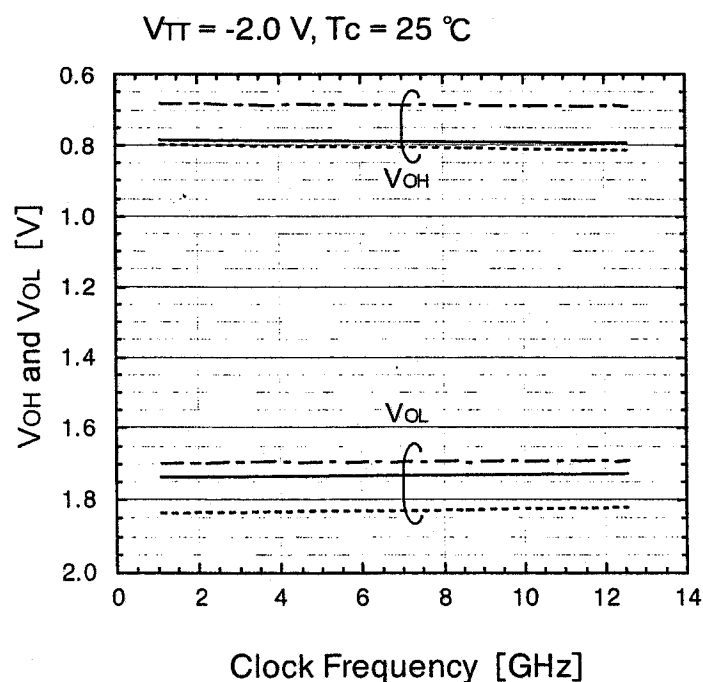
CK : $V_{in} = 0.5 \text{ V}_{p-p}$

Vrefd : Open

Vrefc : Open

Vrefr : Open

Results given here were obtained using the NEL test fixture.



- - - - : $V_{SS} = -3.4 \text{ V}$
 ——— : $V_{SS} = -3.5 \text{ V}$
 - . - . : $V_{SS} = -3.75 \text{ V}$

Measurement Conditions

Din : $V_{IH} = -0.2 \text{ V}, V_{IL} = -0.75 \text{ V}$

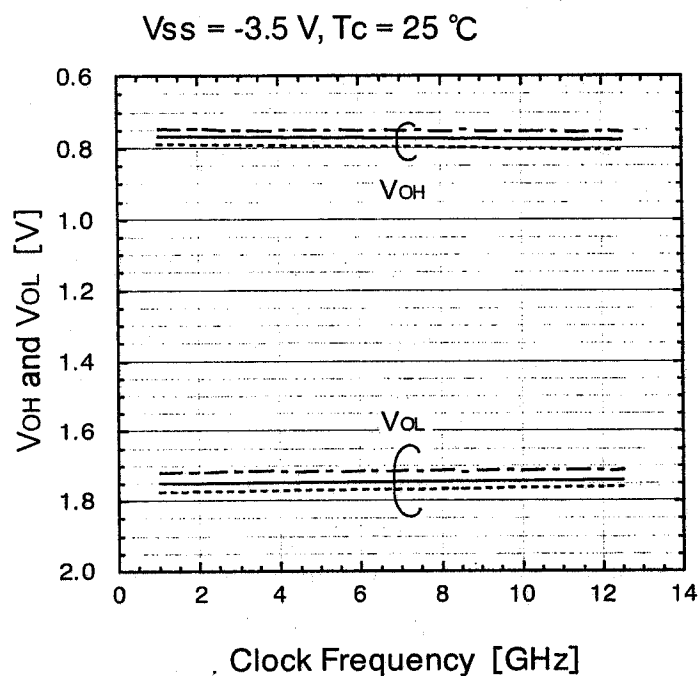
CK : $V_{in} = 0.5 \text{ V}_{p-p}$

Vrefd : Open

Vrefc : Open

Vrefr : Open

Results given here were obtained using the NEL test fixture.

SAMPLE AC CHARACTERISTICS (Q₀~Q₁₅)Measurement ConditionsDin : $V_{IH} = -0.2 \text{ V}, V_{IL} = -0.75 \text{ V}$ CK : $V_{in} = 0.5 \text{ V}_{p-p}$

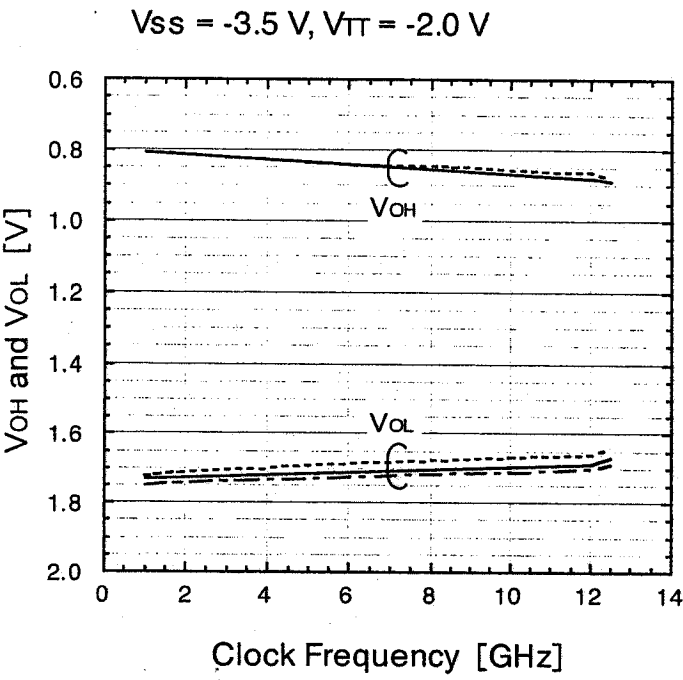
Vrefd : Open

Vrefc : Open

Vrefr : Open

Results given here were obtained
using the NEL test fixture.

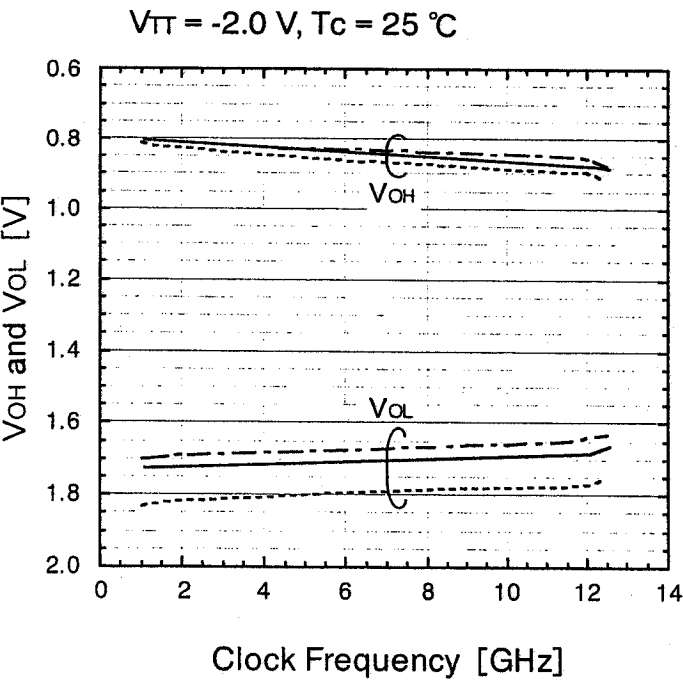
SAMPLE AC CHARACTERISTICS (C16OUT, C16OUT)



--- : $T_c = 0\text{ }^{\circ}\text{C}$
— : $T_c = 25\text{ }^{\circ}\text{C}$
- · - : $T_c = 85\text{ }^{\circ}\text{C}$

Measurement Conditions

Din : $V_{IH} = -0.2\text{ V}, V_{IL} = -0.75\text{ V}$
CK : $V_{in} = 0.5\text{ V}_{p-p}$
Vrefd : Open
Vrefc : Open
Vrefr : Open
Results given here were obtained using the NEL test fixture.

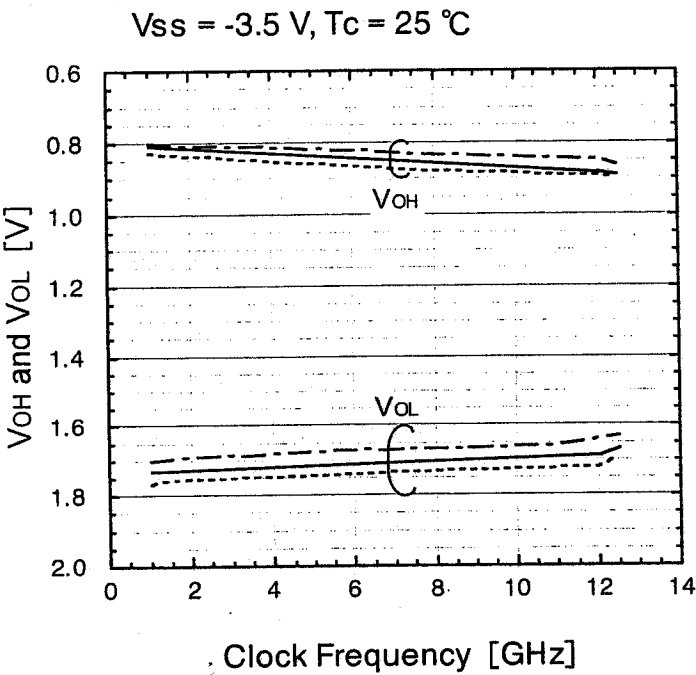


--- : $V_{SS} = -3.4\text{ V}$
— : $V_{SS} = -3.5\text{ V}$
- · - : $V_{SS} = -3.75\text{ V}$

Measurement Conditions

Din : $V_{IH} = -0.2\text{ V}, V_{IL} = -0.75\text{ V}$
CK : $V_{in} = 0.5\text{ V}_{p-p}$
Vrefd : Open
Vrefc : Open
Vrefr : Open
Results given here were obtained using the NEL test fixture.

SAMPLE AC CHARACTERISTICS (C16OUT, C16OUT)



----- : $V_{TT} = -1.9\text{ V}$
————— : $V_{TT} = -2.0\text{ V}$
- - - - - : $V_{TT} = -2.1\text{ V}$

Measurement Conditions

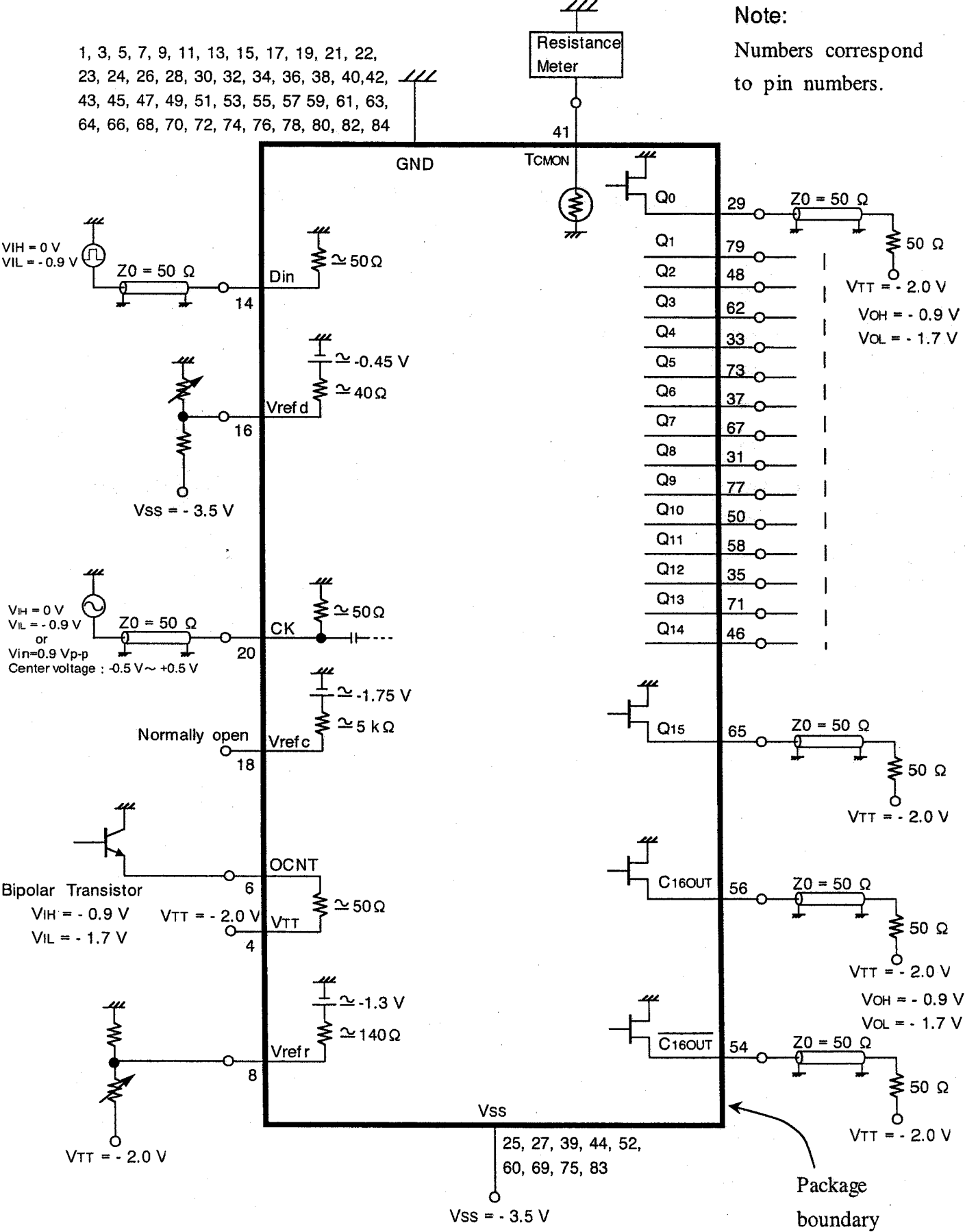
Din : $V_{IH} = -0.2\text{ V}, V_{IL} = -0.75\text{ V}$
CK : $V_{in} = 0.5\text{ V}_{p-p}$
Vrefd : Open
Vrefc : Open
Vrefr : Open

Results given here were obtained using the NEL test fixture.

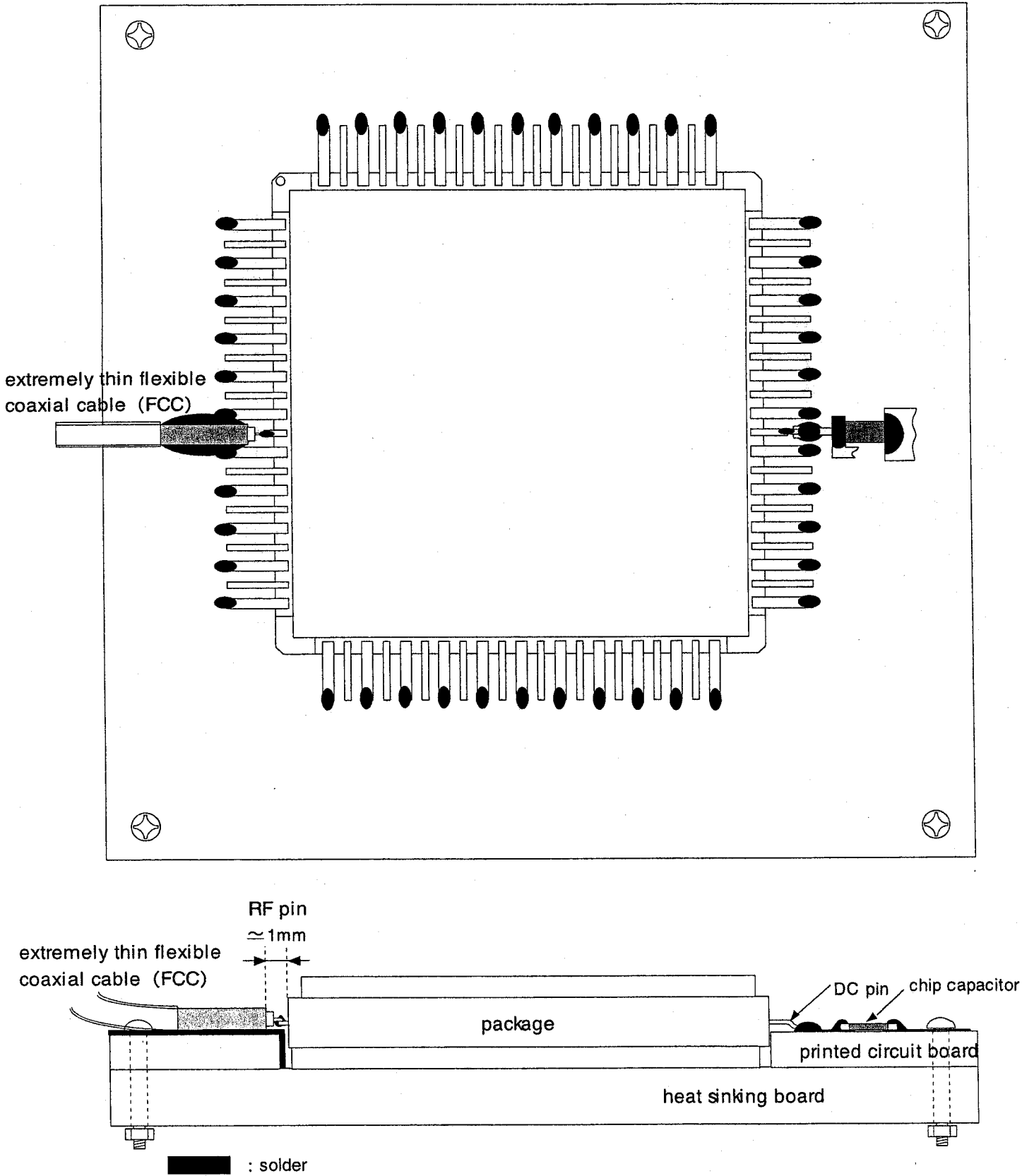
SAMPLE IMPLEMENTATION

1, 3, 5, 7, 9, 11, 13, 15, 17, 19, 21, 22,
23, 24, 26, 28, 30, 32, 34, 36, 38, 40, 42,
43, 45, 47, 49, 51, 53, 55, 57 59, 61, 63,
64, 66, 68, 70, 72, 74, 76, 78, 80, 82, 84

Note:
Numbers correspond
to pin numbers.



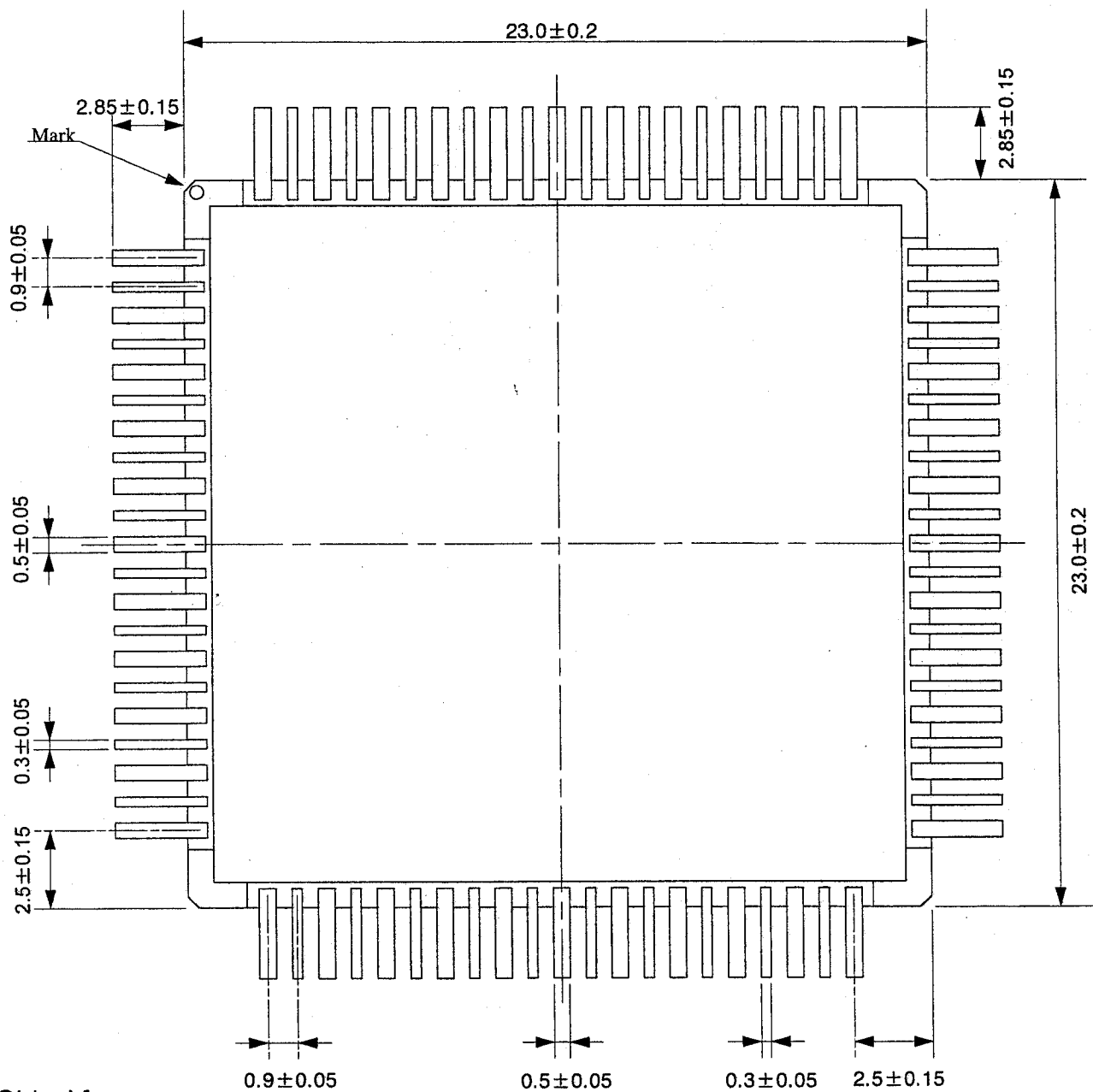
SAMPLE MOUNTING



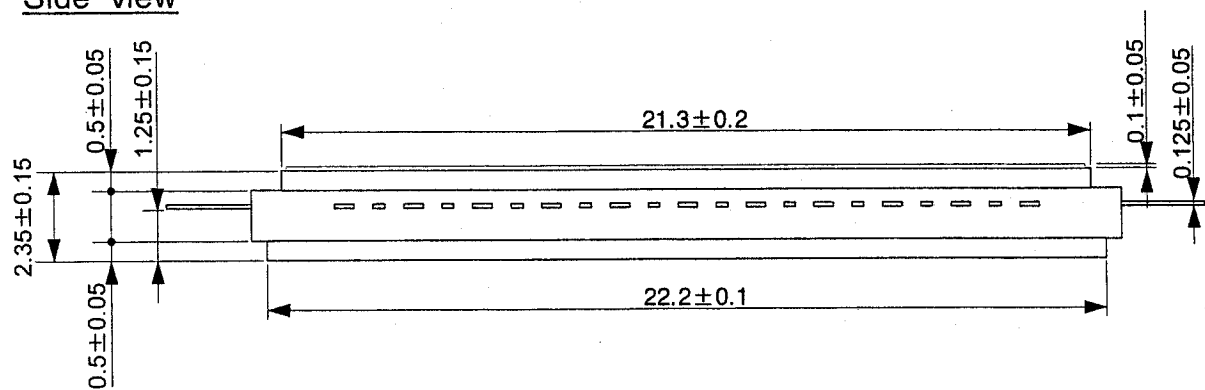
Caution : The package base should be connected to the ground.

TB 84 - PIN PACKAGE DIMENSION (mm)

Top View



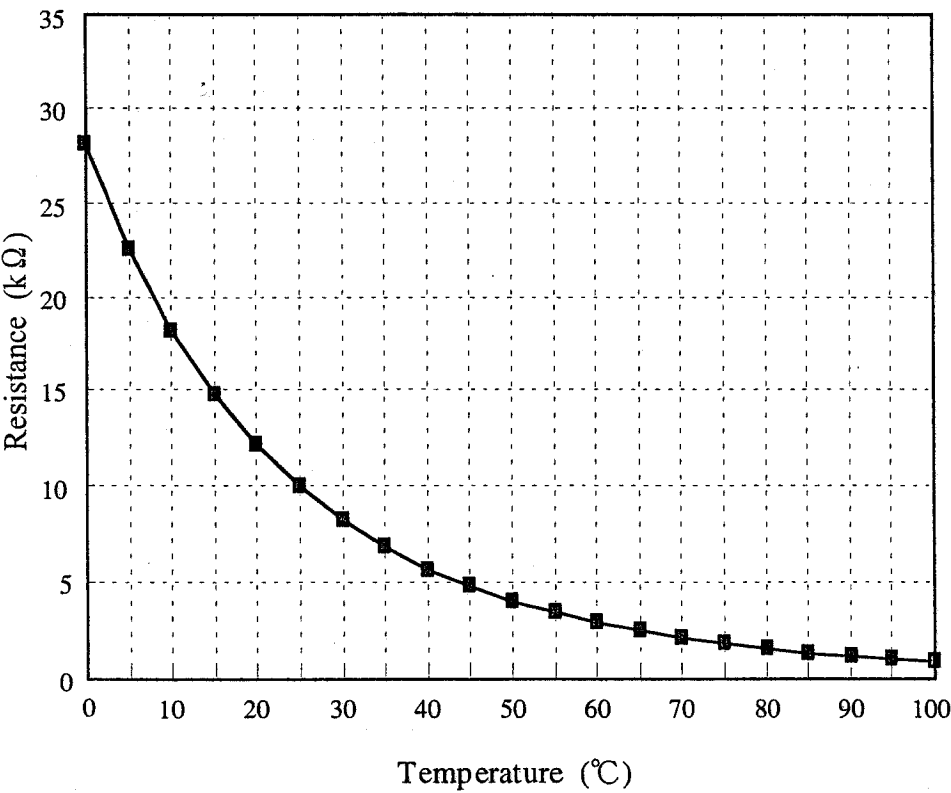
Side View



SAMPLE TEMPERATURE MONITOR

TCMON Resistance Value Versus Case Temperature

TEMPERATURE	RESISTANCE (kΩ)	TEMPERATURE	RESISTANCE (kΩ)
(°C)	TYP.	(°C)	TYP.
0	28.08	55	3.464
5	22.56	60	2.950
10	18.24	65	2.523
15	14.84	70	2.166
20	12.15	75	1.867
25	10.00	80	1.615
30	8.277	85	1.402
35	6.887	90	1.221
40	5.759	95	1.068
45	4.839	100	0.9362
50	4.085		



HANDLING INSTRUCTIONS

Since the NLG4305 is fabricated with GaAs MESFET's (Metal Semiconductor Field Effect Transistors), users are recommended to follow the instructions below to prevent damage to the chip from electro-static discharge.

(1) Power Supply Sequence

The following power supply sequence is recommended.

- 1) Set supply voltage V_{ss} , V_{TT} , V_{refd} , V_{refc} , V_{refr} and GND to 0 V.
- 2) Apply V_{ss} , V_{TT} , V_{refd} , V_{refc} and V_{refr} .

RF signals are recommended to be applied while power supplying and biasing.

(2) Handling Precautions

- 1) Use a conductive working desk connected to the ground (or, a conductive table top connected to the ground).
- 2) Require all handling personnel to wear a conductive bracelet or wrist-strap connected to the ground through a 1 M-ohm resistors.
- 3) Ground all test equipment.
- 4) Ground all soldering iron tips.
- 5) Store IC's and other devices such as chip capacitors in their conductive carriers until they are soldered.

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NLG4305

MEMO

Caution

1. In order to improve products and technology, specifications are subject to change without notice.
2. When using the products, be sure the latest information and specifications are used.
3. Circuit drawings etc. shall be provided for the purpose of information only on application examples not for actual installation of equipment. NTT Electronics Corp. shall not assume any liability for damage that may result from the use of these circuit drawings etc. NTT Electronics Corp. shall not assent to or guarantee any rights of execution for patent rights of the third parties and other rights that may be raised for use of these circuit drawings.
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8. Some of the products use GaAs (gallium arsenide). GaAs powder and vapor are dangerous for humans. Do not break, cut, crush or chemically destroy the products. To dispose of the products, follow the relevant regulations and laws; do not mix with general industrial waste and domestic garbage.
9. Any questions should be directed to the Sales Department of NTT Electronics Corp.

NTT Electronics Corporation

Head Office

: Shibuya Mark City west, 1 - 12 - 1

Dogenzaka, Shibuya - ku,

Tokyo, 150-0043 Japan

Tel : + 81 - 3 - 5456 - 4150

Fax : + 81 - 3 - 5456 - 4155

Ultra - High - Speed Device Group

: 3 - 1, Morinosato Wakamiya, Atsugi - shi,

Kanagawa Pref., 243 - 0198 Japan

Tel : + 81 - 46 - 248 - 6660

Fax : + 81 - 46 - 248 - 8540